

<b>Notice of References Cited</b>	Application/Control No. 10/572,779		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner HENRY S. HU		Art Unit 1796	Page 1 of 1

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*	B	US-7,309,743 B2	12-2007	Kawasaki et al.	525/326.2
*	C	US-5,565,512	10-1996	Saito et al.	525/340
*	D	US-2002/0183457 A1	12-2002	Hintzer et al.	525/326.2
*	E	US-2003/0125463 A1	07-2003	Tatsu et al.	525/101
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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